

**Notice of References Cited**

Application/Control No.

10/554,921

Applicant(s)/Patent Under  
Reexamination  
MIURA ET AL.

Examiner

Jeffrey T. Palenik

Art Unit

1615

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,348,468	02-2002	Ohkuchi et al.	514/252.03
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2002-345940	12-2002	Japan	Tsutomu et al.	A61L 9/12
*	O	WO 02/20624	03-2002	US	Mandel et al.	C08F 6/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Website: <a href="http://www.sigma-aldrich.com">www.sigma-aldrich.com</a> (silica gel product 403563)
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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